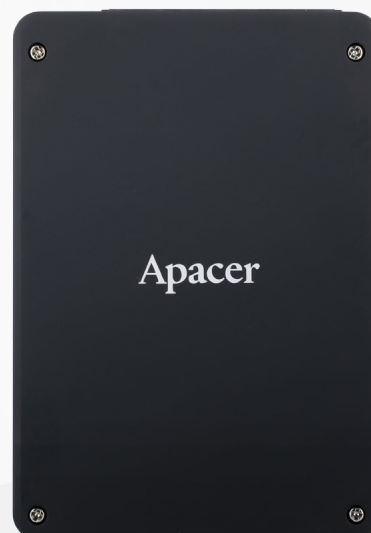


RoHS Compliant

Serial ATA Flash Drive

Industrial SH25P-25 BiCS5 Product Specifications



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Version 1.1



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Specifications Overview:

- **Compliance with SATA Revision 3.2**
 - SATA 6 Gb/s interface
 - ATA-8 command set
 - Backward compatible with SATA 1.5/3 Gb/s interfaces
- **Capacity**
 - 40, 80, 160, 320, 640 GB
- **Performance¹**
 - Burst read/write: 600 MB/sec
 - Sequential read: Up to 560 MB/sec
 - Sequential write: Up to 505 MB/sec
 - Random read (4K): Up to 59,000 IOPS
 - Random write (4K): Up to 63,000 IOPS
- **Flash Management**
 - Low-Density Parity-Check (LDPC) Code
 - Global Wear Leveling
 - Flash bad-block management
 - Flash Translation Layer: Page Mapping
 - S.M.A.R.T.
 - ATA Secure Erase
 - Device Sleep
 - TRIM
 - SLC-liteX (P/E cycles: 100K)
 - DataRAID™²
 - SMART Read Refresh™
 - SATA Power Management
- **NAND Flash Type:** 3D TLC (BiCS5)
- **MTBF:** >3,000,000 hours
- **Endurance (in drive writes per day: DWPD)**
 - 40 GB: 41.75 DWPD
 - 80 GB: 43.29 DWPD
 - 160 GB: 43.95 WPD
 - 320 GB: 43.29 DWPD
 - 640 GB: 37.31 DWPD
- **Temperature Range**
 - Operating (Tc):
 - Standard: 0°C to 70°C
 - Wide: -40°C to 85°C
 - Storage (Ta): -55°C to 100°C
- **Supply Voltage**
 - 5V ± 10%
- **Power Consumption¹**
 - Active mode (Max.): 330 mA
 - Idle mode: 60 mA
- **Connector Type**
 - 7-pin SATA signal connector
 - 15-pin SATA power connector
- **Security**
 - AES 256-bit hardware encryption
- **Reliability**
 - CorePower
 - Thermal Sensor
 - End-to-End Data Protection
- **Physical Characteristics**
 - Form factor: 2.5"
 - Dimensions: 100.00 x 69.85 x 6.90, unit: mm
 - Net weight: 53.1g ± 5%
- **RoHS Compliant**

Notes:

1. Varies from capacities. The values for performances and power consumptions presented are typical and may vary depending on flash configurations or platform settings. The term idle refers to the standby state of the device.
2. Not supported on 40GB

Table of Contents

1. General Description	4
2. Functional Block	4
3. Pin Assignments.....	5
4. Product Specifications.....	7
4.1 Capacity.....	7
4.2 Performance	7
4.3 Environmental Specifications	8
4.4 Mean Time Between Failures (MTBF)	8
4.5 Certification and Compliance.....	8
4.6 Endurance	9
5. Flash Management	10
5.1 Error Correction/Detection.....	10
5.2 Bad Block Management	10
5.3 Global Wear Leveling	10
5.4 Flash Translation Layer – Page Mapping.....	10
5.5 TRIM	10
5.6 ATA Secure Erase	11
5.7 Device Sleep (DevSleep or DEVSLP) Mode.....	11
5.8 SLC-liteX.....	11
5.9 DataRAID™	11
5.10 SMART Read Refresh™	11
5.11 SATA Power Management.....	12
6. Security and Reliability Features	13
6.1 CorePower.....	13
6.2 Advanced Encryption Standard	13
6.3 Thermal Sensor	13
6.4 End-to-End Data Protection.....	14
7. Software Interface	15
7.1 Command Set.....	15
7.2 S.M.A.R.T.	16
8. Electrical Specifications.....	17

8.1 Operating Voltage.....	17
8.2 Power Consumption	17
9. Mechanical Specifications.....	18
10. Product Ordering Information.....	19
10.1 Product Code Designations.....	19
10.2 Valid Combinations.....	20

1. General Description

Apacer's SH25P-25 is a well-balanced solid-state disk (SSD) drive with a standard form factor and excellent performance. Designed with a SATA 6 Gb/s interface, SH25P-25 fully complies with the latest SATA Revision 3.2 interface specifications and delivers exceptional read/write speeds, making it the ideal companion for heavy-duty industrial or server operations.

Utilizing 3D NAND technology to offer expanded capacity of up to 640GB and boasting superior power efficiency compared to 2D NAND, SH25P-25 is equipped with a robust SATA controller supporting on-the-module ECC and an efficient wear leveling scheme. Additionally, it incorporates an LDPC (Low Density Parity Check) ECC engine and SLC-liteX technology, supporting P/E cycles of up to 100,000 times to extend SSD endurance and enhance data reliability.

Featuring CorePower technology, SH25P-25 guarantees the integrity and stability of data transmission in the event of an unexpected power loss. This is achieved through a backup power supply featuring tantalum capacitors, allowing sufficient time to transfer all cached data to NAND flash. Furthermore, SH25P-25 is outfitted with a built-in thermal sensor to monitor the SSD temperature via S.M.A.R.T commands, preventing overheating. For highly-intensive applications, End-to-End Data Protection guarantees data integrity at multiple points along the transmission path, enabling dependable data transfers.

Security-wise, Advanced Encryption Standard (AES) ensures data security and provides users with peace of mind knowing their data is safeguarded against unauthorized use at all times. SH25P-25 also adopts the latest page mapping file translation layer and comes with various implementations including flash block management, TRIM, ATA secure erase, device sleep, DataRAID, SMART Read Refresh, and power saving modes.

With exceptional performance, trustable reliability, and enhanced data protection, SH25P-25 is definitely the ideal storage or cache solution for a variety of applications ranging from industrial, imaging, computing to enterprise markets.

2. Functional Block

Apacer SH25P-25 includes a single-chip controller and flash media. The controller integrates the flash management unit to support multi-channel, multi-bank flash arrays. Figure 2-1 shows the functional block diagram.

Note: The actual number of NAND flash used on Apacer SH25P-25 varies from capacities. The illustration is for reference only.

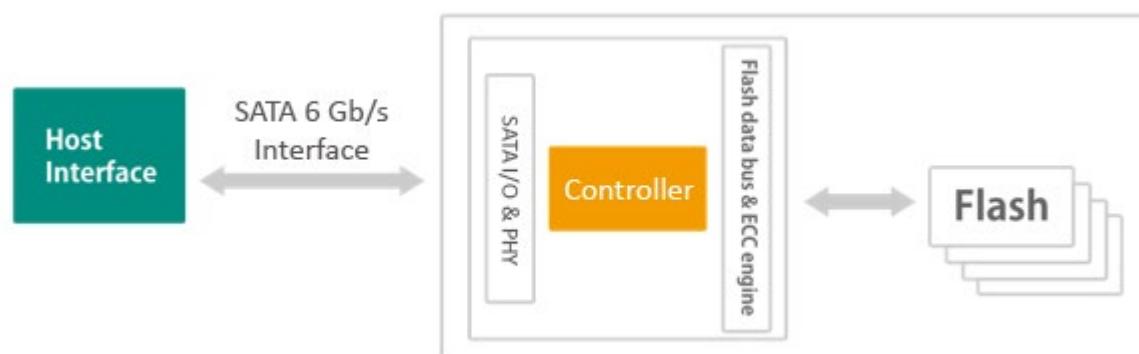


Figure 2-1 Functional Block Diagram

3. Pin Assignments

Table 3-1 describes the signal segment, and Table 3-2, power segment.

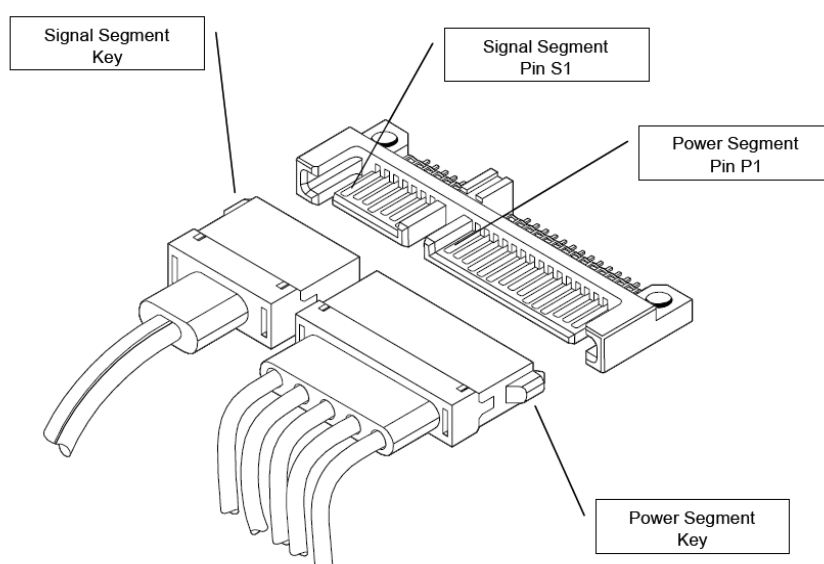


Figure 3-1 SATA Connectors

Table 3-1 Signal Segment

Pin	Type	Description
S1	GND	
S2	RxP	+ Differential Receive Signal
S3	RxN	- Differential Receive Signal
S4	GND	
S5	TxN	- Differential Transmit Signal
S6	TxP	+ Differential Transmit Signal
S7	GND	

Table 3-2 Power Segment

Pin	Signal/Description
P1	Unused (3.3V)
P2	Unused (3.3V)
P3	Device Sleep
P4	Reserved for Apacer use only ¹
P5	Ground
P6	Ground
P7	5V
P8	5V
P9	5V
P10	Ground
P11	Reserved for Apacer use only ¹
P12	Ground
P13	Unused (12V)
P14	Unused (12V)
P15	Unused (12V)

Note:

1. Reserved by Apacer, please do not connect to a host.

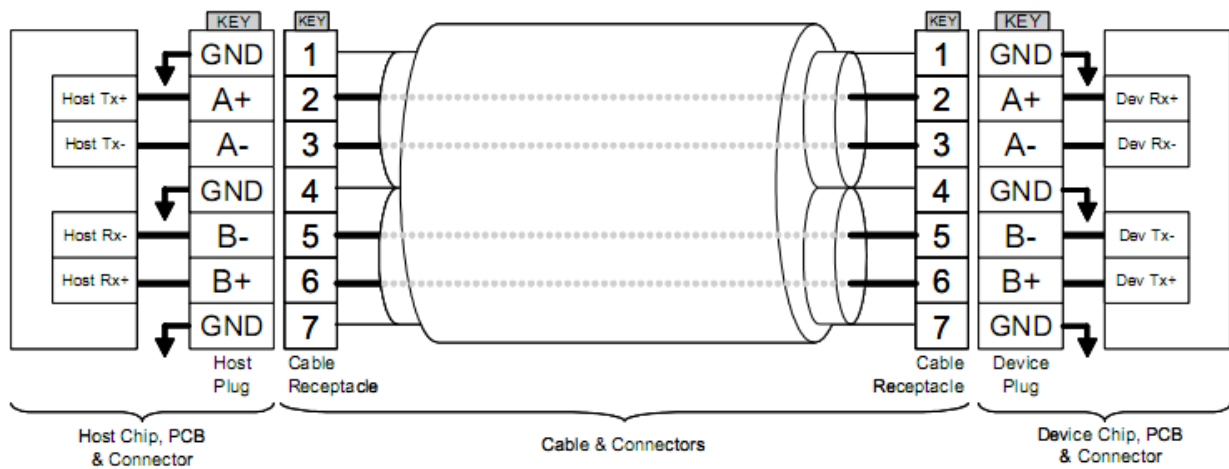


Figure 3-2 SATA Cable/Connector Connection Diagram

The connector on the left represents the Host with TX/RX differential pairs connected to a cable. The connector on the right shows the Device with TX/RX differential pairs also connected to the cable. Notice also the ground path connecting the shielding of the cable to the Cable Receptacle.

4. Product Specifications

4.1 Capacity

Capacity specifications of SH25P-25 are available as shown in Table 4-1. It lists the specific capacity and the default numbers of heads, sectors and cylinders for each product line.

Table 4-1 Capacity Specifications

Capacity	Total bytes	Cylinders	Heads	Sectors	Total LBA
40 GB	40,018,599,936	16,383	16	63	78,161,328
80 GB	80,026,361,856	16,383	16	63	156,301,488
160 GB	160,041,885,696	16,383	16	63	312,581,808
320 GB	320,072,933,376	16,383	16	63	625,142,448
640 GB	640,135,028,736	16,383	16	63	1,250,263,728

Notes:

- Display of total bytes varies from operating systems.
- 1 GB = 1,000,000,000 bytes; 1 sector = 512 bytes.
- LBA count addressed in the table above indicates total user storage capacity and will remain the same throughout the lifespan of the device. However, the total usable capacity of the SSD is most likely to be less than the total physical capacity because a small portion of the capacity is reserved for device maintenance usages.

4.2 Performance

Performance of SH25P-25 is listed below in Table 4-2.

Table 4-2 Performance Specifications

Capacity	40 GB	80 GB	160 GB	320 GB	640 GB
Performance					
Sequential Read (MB/s)	560	560	560	560	560
Sequential Write (MB/s)	220	400	500	500	505
4K Random Read (IOPS)	16,000	37,000	57,000	59,000	52,000
4K Random Write (IOPS)	35,000	63,000	63,000	60,000	57,000

Notes:

- Results may differ from various flash configurations or host system setting.
- Sequential read/write is based on CrystalDiskMark 8.0.4 with file size 1,000MB.
- Random read/write is measured using IOMeter with Queue Depth 32.

4.3 Environmental Specifications

Environmental specifications of SH25P-25 product are shown in Table 4-3.

Table 4-3 Environmental Specifications

Parameter	Type	Specifications
Temperature	Operating (Tc)	0°C to 70°C (Standard); -40°C to 85°C (Wide)
	Non-operating (Ta)	-55°C to 100°C
Vibration	Operating	7.69 GRMS, 20~2000 Hz/random (compliant with MIL-STD-810G)
	Non-operating	4.02 GRMS, 15~2000 Hz/random (compliant with MIL-STD-810G)
Shock	Operating	Acceleration, 50(G)/11(ms)/half sine (compliant with MIL-STD-202G)
	Non-operating	Acceleration, 1500(G)/0.5(ms)/half sine (compliant with MIL-STD-883K)

Notes:

- This Environmental Specification table indicates the conditions for testing the device. Real world usages may affect the results.
- Tc: case temperature; Ta: ambient temperature. The operating temperature is determined by the case temperature. Adequate airflow is advisable as it enables the device to maintain optimal temperatures, especially in environments with heavy workloads.

4.4 Mean Time Between Failures (MTBF)

Mean Time Between Failures (MTBF) is predicted based on reliability data for the individual components in SH25P-25. The prediction result for SH25P-25 is more than 3,000,000 hours.

Note: The MTBF is predicated and calculated based on “Telcordia Technologies Special Report, SR-332, Issue 3” method.

4.5 Certification and Compliance

SH25P-25 complies with the following standards:

- CE
- UKCA
- FCC
- RoHS
- MIL-STD-810G

4.6 Endurance

The endurance of a storage device is predicted by Drive Writes Per Day based on several factors related to usage, such as the amount of data written into the drive, block management conditions, and daily workload for the drive. Thus, key factors, such as Write Amplifications and the number of P/E cycles, can influence the lifespan of the drive.

Table 4-4 Endurance Specifications

Capacity	Drive Writes Per Day
40 GB	41.75
80 GB	43.29
160 GB	43.95
320 GB	43.29
640 GB	37.71

Notes:

- This estimation complies with JEDEC JESD-219, Enterprise endurance workload of random data with payload size distribution.
- Flash vendor guaranteed 3D SLC-liteX P/E cycle: 100K
- WAF may vary from capacity, flash configurations and writing behavior on each platform.
- 1 Terabyte = 1,024 GB
- DWPD (Drive Writes Per Day) is calculated based on the number of times that user overwrites the entire capacity of an SSD per day of its lifetime during the warranty period. (3D SLC-liteX warranty: 5 years)

5. Flash Management

5.1 Error Correction/Detection

SH25P-25 implements a hardware ECC scheme, based on the Low Density Parity Check (LDPC). LDPC is a class of linear block error correcting code which has apparent coding gain over BCH code because LDPC code includes both hard decoding and soft decoding algorithms. With the error rate decreasing, LDPC can extend SSD endurance and increase data reliability while reading raw data inside a flash chip.

5.2 Bad Block Management

Current production technology is unable to guarantee total reliability of NAND flash memory array. When a flash memory device leaves factory, it comes with a minimal number of initial bad blocks during production or out-of-factory as there is no currently known technology that produce flash chips free of bad blocks. In addition, bad blocks may develop during program/erase cycles. Since bad blocks are inevitable, the solution is to keep them in control. Apacer flash devices are programmed with ECC, page mapping technique and S.M.A.R.T to reduce invalidity or error. Once bad blocks are detected, data in those blocks will be transferred to free blocks and error will be corrected by designated algorithms.

5.3 Global Wear Leveling

Flash memory devices differ from Hard Disk Drives (HDDs) in terms of how blocks are utilized. For HDDs, when a change is made to stored data, like erase or update, the controller mechanism on HDDs will perform overwrites on blocks. Unlike HDDs, flash blocks cannot be overwritten and each P/E cycle wears down the lifespan of blocks gradually. Repeatedly program/erase cycles performed on the same memory cells will eventually cause some blocks to age faster than others. This would bring flash storages to their end of service term sooner. Global wear leveling is an important mechanism that levels out the wearing of all blocks so that the wearing-down of all blocks can be almost evenly distributed. This will increase the lifespan of SSDs.

5.4 Flash Translation Layer – Page Mapping

Page mapping is an advanced flash management technology whose essence lies in the ability to gather data, distribute the data into flash pages automatically, and then schedule the data to be evenly written. Page-level mapping uses one page as the unit of mapping. The most important characteristic is that each logical page can be mapped to any physical page on the flash memory device. This mapping algorithm allows different sizes of data to be written to a block as if the data is written to a data pool and it does not need to take extra operations to process a write command. Thus, page mapping is adopted to increase random access speed and improve SSD lifespan, reduce block erase frequency, and achieve optimized performance and lifespan.

5.5 TRIM

TRIM is a SATA command that helps improve the read/write performance and efficiency of solid-state drives (SSD). The command enables the host operating system to inform SSD controller which blocks contain invalid data, mostly because of the erase commands from host. The invalid will be discarded permanently and the SSD will retain more space for itself.

5.6 ATA Secure Erase

ATA Secure Erase is an ATA disk purging command currently embedded in most of the storage drives. Defined in ATA specifications, (ATA) Secure Erase is part of Security Feature Set that allows storage drives to erase all user data areas. The erase process usually runs on the firmware level as most of the ATA-based storage media currently in the market are built-in with this command. ATA Secure Erase can securely wipe out the user data in the drive and protects it from malicious attack.

5.7 Device Sleep (DevSleep or DEVSLP) Mode

Device Sleep is a feature that allows SATA devices to enter a low power mode by designating a particular pin as DEVSLP signal with an aim to reducing power consumption.

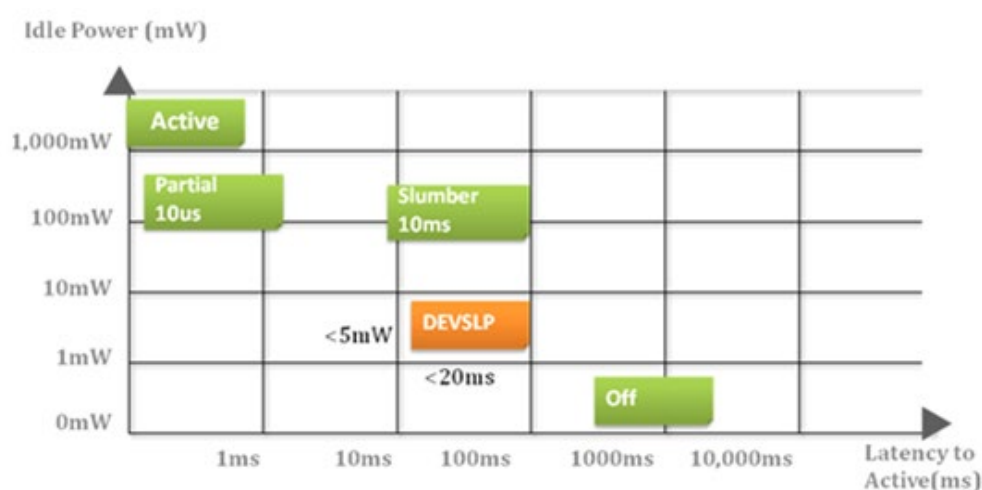


Figure 5-1 Device Sleep

5.8 SLC-liteX

Apacer's 3D NAND SLC-liteX technology breaks through the limitations of existing technology and provides up to 100,000 P/E cycles, which is over 33 times more than MLC or industrial 3D TLC. Powered by carefully selected NAND components, the firmware structure is specifically optimized to enhance NAND flash stability during daily operations, and the error handling algorithm is significantly improved to avoid any unexpected ECC errors. The longest lifespans are therefore available at reasonable cost.

5.9 DataRAID™

Apacer's DataRAID algorithm applies an additional level of protection and error-checking. Using this algorithm, a certain amount of space is given over to aggregating and resaving the existing parity data used for error checking. So, in the event that data becomes corrupted, the parity data can be compared to the existing uncorrupted data and the content of the corrupted data can be rebuilt.

5.10 SMART Read Refresh™

Apacer's SMART Read Refresh plays a proactive role in avoiding read disturb errors from occurring to ensure health status of all blocks of NAND flash. Developed for read-intensive applications in particular, SMART Read Refresh is employed to make sure that during read operations, when the read operation threshold is reached, the data is refreshed by re-writing it to a different block for subsequent use.

5.11 SATA Power Management

By complying with SATA 6 Gb/s specifications, the SSD supports the following SATA power saving modes:

- ACTIVE: PHY ready, full power, TX & RX operational
- PARTIAL: Reduces power, resumes in under 10 μ s (microseconds)
- SLUMBER: Reduces power, resumes in under 10 ms (milliseconds)
- HIPM: Host-Initiated Power Management
- DIPM: Device-Initiated Power Management
- AUTO-SLUMBER: Automatic transition from partial to slumber.
- Device Sleep (DevSleep or DEVSLP): PHY powered down; power consumption \leq 5 mW; host assertion time \leq 10 ms; exit timeout from this state \leq 20 ms (unless specified otherwise in SATA Identify Device Log).

Note: The behaviors of power management features would depend on host/device settings.

6. Security and Reliability Features

6.1 CorePower

If the voltage supply is cut, for instance, accidental power off or sudden blackout, the data would be shortly lost. To protect SSD data integrity from this disastrous scenario, Apacer has developed the hardware-based technology named Apacer CorePower. The CorePower equips SSDs with tantalum capacitors that can deliver urgent power current so that the flash controller can take this extended moment to flush cached data and essential metadata into NAND Flash blocks.

In addition to tantalum capacitors which guarantee SSD data integrity, an inbuilt IC detector also serves the same purpose as well as ensures the stability of data transmission. The detector is designed to take proactive measures for the aforementioned disastrous scenario. When supply voltage drops below a minimum threshold, the detector will send out signals to the flash controller notifying it to stop operating to prevent poor performance or erratic operation. In the meanwhile, signals will also be sent to DRAM to have cached data flushed into NAND Flash blocks so as to avoid data loss, similar to the function performed by tantalum capacitors.

SH25P-25 is equipped with tantalum capacitors which have lower power leakage, higher operating temperature and higher volume-efficiency (high capacitance in small volume) than many other types of capacitors. The compact size and the high reliability are ideal for embedded computing systems.

6.2 Advanced Encryption Standard

Advanced Encryption Standard (AES) is a specification for the encryption of electronic data. AES has been adopted by the U.S. government since 2001 to protect classified information and is now widely implemented in embedded computing applications. The AES algorithm used in software and hardware is symmetric so that encrypting/decrypting requires the same encryption key. Without the key, the encrypted data is inaccessible to ensure information security.

Notably in flash memory applications, AES 256-bit hardware encryption is the mainstream to protect sensitive or confidential data. The hardware encryption provides better performance, reliability, and security than software encryption. It uses a dedicated processor, which is built inside the controller, to process the encryption and decryption. This enormously shortens the processing time and makes it efficient.

6.3 Thermal Sensor

Apacer Thermal Sensor is a digital temperature sensor with serial interface. By using a designated pin for transmission, storage device owners are able to read temperature data.

6.4 End-to-End Data Protection

End-to-End Data Protection is a feature implemented in Apacer SSD products that extends error control to cover the entire path from the host computer to the drive and back, and ensure data integrity at multiple points in the path to enable reliable delivery of data transfers. Unlike ECC which does not exhibit the ability to determine the occurrence of errors throughout the process of data transmission, End-to-End Data Protection allows SSD controller to identify an error created anywhere in the path and report the error to the host computer before it is written to the drive. This error-checking and error-reporting mechanism therefore guarantees the trustworthiness and reliability of the SSD.

7. Software Interface

7.1 Command Set

This section defines the software requirements and the format of the commands the host sends to SH25P-25. Commands are issued to SH25P-25 by loading the required registers in the command block with the supplied parameters, and then writing the command code to the Command register.

Table 7-1 Command Set

Code	Command	Code	Command
E5h	CHECK POWER MODE	F4h	SECURITY ERASE UNIT
06h	DATA SET MANAGEMENT	F5h	SECURITY FREEZE LOCK
92h	DOWNLOAD MICROCODE	F1h	SECURITY SET PASSWORD
90h	EXECUTE DEVICE DIAGNOSTIC	F2h	SECURITY UNLOCK
E7h	FLUSH CACHE	70h	SEEK
EAh	FLUSH CACHE EXT	EFh	SET FEATURES
ECh	IDENTIFY DEVICE	C6h	SET MULTIPLE MODE
E3h	IDLE	E6h	SLEEP
E1h	IDLE IMMEDIATE	B0h	SMART
91h	INITIALIZE DEVICE PARAMETERS	E2h	STANDBY
E4h	READ BUFFER	E0h	STANDBY IMMEDIATE
C8h	READ DMA	E8h	WRITE BUFFER
25h	READ DMA EXT	CAh	WRITE DMA
60h	READ FPDMA QUEUED	35h	WRITE DMA EXT
C4h	READ MULTIPLE	3Dh	WRITE DMA FUA EXT
29h	READ MULTIPLE EXT	61h	WRITE FPDMA QUEUED
2Fh	READ LOG EXT	3Fh	WRITE LOG EXT
47h	READ LOG DMA EXT	57h	WRITE LOG DMA EXT
20h	READ SECTOR	C5h	WRITE MULTIPLE
24h	READ SECTOR EXT	39h	WRITE MULTIPLE EXT
40h	READ VERIFY SECTORS	CEh	WRITE MULTIPLE FUA EXT
42h	READ VERIFY SECTORS EXT	30h	WRITE SECTOR
10h	RECALIBRATE	34h	WRITE SECTOR EXT
F6h	SECURITY DISABLE PASSWORD	45h	WRITE UNCORRECTABLE EXT
F3h	SECURITY ERASE PREPARE		

7.2 S.M.A.R.T.

SMART, an acronym for Self-Monitoring, Analysis and Reporting Technology, is an open standard that allows a hard disk drive to automatically detect its health and report potential failures. When a failure is recorded by SMART, users can choose to replace the drive to prevent unexpected outage or data loss. Moreover, SMART can inform users of impending failures while there is still time to perform proactive actions, such as copy data to another device.

Table 7-2 SMART Subcommand Set

Code	SMART Subcommand
D0h	READ DATA
D1h	READ ATTRIBUTE THRESHOLDS
D2h	ENABLE/DISABLE ATTRIBUTE AUTOSAVE
D4h	EXECUTE OFF-LINE IMMEDIATE
D5h	SMART READ LOG
D6h	SMART WRITE LOG
D8h	ENABLE OPERATIONS
D9h	DISABLE OPERATIONS
DAh	RETURN STATUS

Table 7-3 General SMART Attribute Structure

Byte	Description
0	ID (Hex)
1 – 2	Status Flag
3	Value
4	Worst
5*-11	Raw Data

*Byte 5: LSB

Table 7-4 SMART Attribute ID List

ID (Hex)	Attribute Name
9 (0x09)	Power-on Hours
12 (0x0C)	Power Cycle Count
163 (0xA3)	Maximum Erase Count
164 (0xA4)	Average Erase Count
166 (0xA6)	Total Later Bad Block Count
167 (0xA7)	SSD Protect Mode (Vendor Specific)
168 (0xA8)	SATA PHY Error Count
171 (0xAB)	Program Fail Count
172 (0xAC)	Erase Fail Count
175 (0xAF)	Bad Cluster Table Count
192 (0xC0)	Unexpected Power Loss Count
194 (0xC2)	Temperature
231 (0xE7)	Lifetime Left
241 (0xF1)	Total Sectors of Write

8. Electrical Specifications

8.1 Operating Voltage

Table 8-1 lists the supply voltage for SH25P-25.

Table 8-1 Operating Range

Item	Range
Supply Voltage	5V \pm 10%

8.2 Power Consumption

Table 8-2 lists the power consumption for SH25P-25.

Table 8-2 Power Consumption

Capacity Mode	Unit	40 GB	80 GB	160 GB	320 GB	640 GB
Active (Max.)	mA	255	260	330	300	285
Idle		50	50	60	50	55

Notes:

- All values are typical and may vary depending on flash configurations or host system settings.
- Power consumption is measured using CrystalDiskMark 8.0.4 with file size 1,000MB.

9. Mechanical Specifications

Table 9-1 Physical Information

Parameter	Unit	40 GB	80 GB	160 GB	320 GB	640 GB
Length	mm	100.00 ± 0.20				
Width		69.85 ± 0.20				
Height		$6.90 +0.10/-0.40$				
Weight	g $\pm 5\%$	51.1	52.3	52.9	53.1	52.6

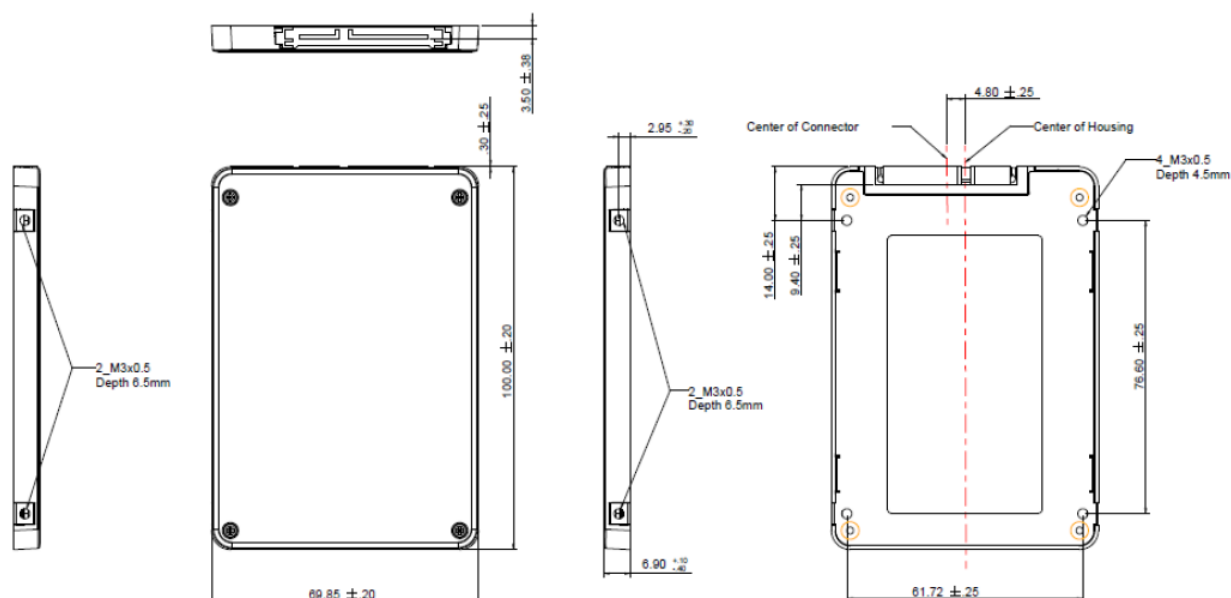


Figure 9-1 Physical Dimensions

10. Product Ordering Information

10.1 Product Code Designations

Apacer's SH25P-25 SSD is available in different configurations and densities. See the chart below for a comprehensive list of options for the SH25P-25 series devices.

Code	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16
	A	E	2	.	P	1	9	X	X	C	.	0	0	1	G	B

Code 1-3 (Product Line & Form Factor)	SATA+25 Half
Code 5-6 (Model/Solution)	SH25P
Code 7-8 (Product Capacity)	9H: 40GB 9J: 80GB 9K: 160GB 9L: 320GB 9M: 640GB
Code 9 (Flash Type & Product Temp)	Y: 3D TLC SLC-liteX Standard Temperature Z: 3D TLC SLC-liteX Wide Temperature
Code 10 (Product Spec)	2.5" 7mm plastic housing
Code 12-14 (Version Number)	Random numbers generated by system
Code 15-16 (Firmware Version)	SLC-liteX Thermal Sensor DEVSLP

10.2 Valid Combinations

The following table lists the available models of the SH25P-25 series which are in mass production or will be in mass production. Consult your Apacer sales representative to confirm availability of valid combinations and to determine availability of new combinations.

Capacity	Standard Temperature	Wide Temperature
40GB	AE2.P19HYC.001GB	AE2.P19HZC.001GB
80GB	AE2.P19JYC.001GB	AE2.P19JZC.001GB
160GB	AE2.P19KYC.001GB	AE2.P19KZC.001GB
320GB	AE2.P19LYC.001GB	AE2.P19LZC.001GB
640GB	AE2.P19MYC.001GB	AE2.P19MZC.001GB

Revision History

Revision	Description	Date
1.0	Initial release	4/2/2024
1.1	Added 640GB support	5/7/2024

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